INTEGRATED CIRCUITS

DATA SHEET

74F10 Triple 3-input NAND gate74F11 Triple 3-input AND gate

Product specification

1989 Sep 20

IC15 Data Handbook





Gates 74F10, 74F11

74F10 Triple 3-input NAND gate 74F11 Triple 3-input AND gate

TYPE	TYPICAL PROPAGATION DELAY	TYPICAL SUPPLY CURRENT (TOTAL)
74F10	3.5ns	3.3mA
74F11	4.2ns	5.3mA

ORDERING INFORMATION

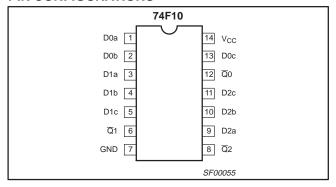
DESCRIPTION	COMMERCIAL RANGE V_{CC} = 5V $\pm 10\%$, T_{amb} = 0°C to +70°C	PKG DWG #		
14-pin plastic DIP	N74F10N, N74F11N	SOT27-1		
14-pin plastic SO	N74F10D, N74F11D	SOT108-1		

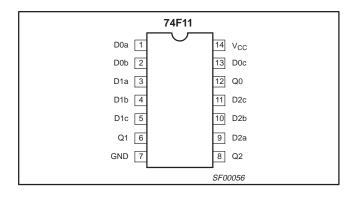
INPUT AND OUTPUT LOADING AND FAN OUT TABLE

PINS	DESCRIPTION	74F (U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
Dna, Dnb, Dnc	Data inputs	1.0/1.0	20μA/0.6mA
Qn	Data output (74F10)	50/33	1.0mA/20mA
Qn	Data output (74F11)	50/33	1.0mA/20mA

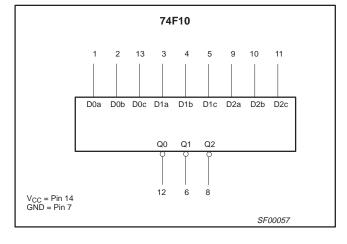
NOTE: One (1.0) FAST unit load is defined as: 20μA in the High state and 0.6mA in the Low state.

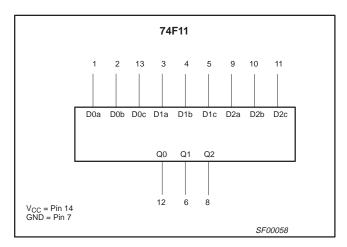
PIN CONFIGURATIONS





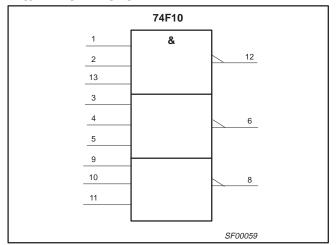
LOGIC SYMBOLS

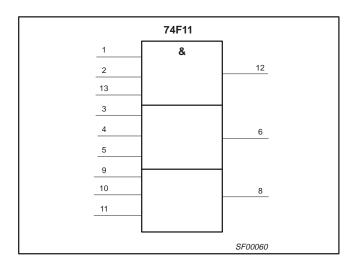




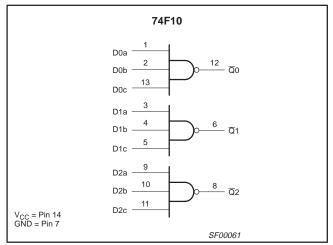
Gates 74F10, 74F11

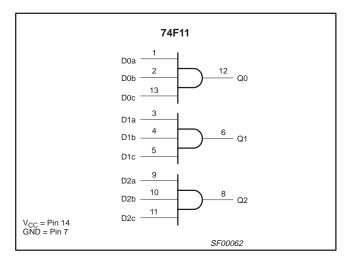
IEC/IEEE SYMBOLS





LOGIC DIAGRAMS





FUNCTION TABLE

	INPUTS		OUTPUTS							
	INPUIS		74F10	74F11						
Dna	Dnb	Dnc	Qn	Qn						
L	L	L	Н	L						
L	L	Н	Н	L						
L	Н	L	Н	L						
L	Н	Н	Н	L						
Н	L	L	Н	L						
н	L	Н	Н	L						
Н	Н	L	Н	L						
Н	Н	Н	L	н						

NOTES:

H = High voltage level
 L = Low voltage level

74F10, 74F11 Gates

ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limit set forth in this table may impair the useful life of the device. Unless otherwise noted these limits are over the operating free-air temperature range.)

SYMBOL	PARAMETER	RATING	UNIT
V _{CC}	Supply voltage	-0.5 to +7.0	V
V _{IN}	Input voltage	-0.5 to +7.0	V
I _{IN}	Input current	−30 to +5	mA
V _{OUT}	Voltage applied to output in High output state	–0.5 to V _{CC}	V
I _{OUT}	Current applied to output in Low output state	40	mA
T _{amb}	Operating free-air temperature range	0 to +70	°C
T _{stg}	Storage temperature range	-65 to +150	°C

RECOMMENDED OPERATING CONDITIONS

CVMDOL	DADAMETER		LIMITS						
SYMBOL	PARAMETER	MIN	NOM	MAX	UNIT				
V _{CC}	Supply voltage	4.5	5.0	5.5	V				
V _{IH}	High-level input voltage	2.0			V				
V _{IL}	Low-level input voltage			0.8	V				
I _{IK}	Input clamp current			-18	mA				
I _{OH}	High-level output current			-1	mA				
I _{OL}	Low-level output current			20	mA				
T _{amb}	Operating free air temperature range	0		+70	°C				

DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

CVMDOL	DADAMET	-0		TEST CONDITIO	NC1		LIMITS		LINUT	
SYMBOL	PARAMETE	=K		TEST CONDITIO	M9.	MIN	TYP ²	MAX	UNIT	
\/ -	High lovel output voltage			$V_{CC} = MIN, V_{IL} = MAX$	±10%V _{CC}	2.5			V	
V _{OH}	High-level output voltage			$V_{IH} = MIN, I_{OH} = MAX$	±5%V _{CC}	2.7	3.4		V	
\ <u></u>	Low lovel output voltage			$V_{CC} = MIN, V_{IL} = MAX$	±10%V _{CC}		0.35	0.50	V	
V _{OL}	Low-level output voltage			$V_{IH} = MIN, I_{OI} = MAX$		0.35	0.50	V		
V _{IK}	Input clamp voltage			$V_{CC} = MIN, I_I = I_{IK}$		-0.73	-1.2	V		
I _I	Input current at maximum	input volta	age	$V_{CC} = MAX, V_I = 7.0V$			100	μΑ		
I _{IH}	High-level input current			$V_{CC} = MAX, V_I = 2.7V$			20	μΑ		
I _{IL}	Low-level input current			$V_{CC} = MAX, V_I = 0.5V$			-0.6	mA		
Ios	Short-circuit output curren	t ³		$V_{CC} = MAX$		-60		-150	mA	
		74F10	I _{CCH}	V - MAY	$V_{IN} = GND$		1.8	2.1	mA	
	Cupply ourrant (total)	741-10	I _{CCL}	V _{CC} = MAX	$V_{IN} = 4.5V$		6.0	7.7	IIIA	
Icc	Supply current (total)	74F11 I _{CCH}		V - MAY	$V_{IN} = 4.5V$		4.7	6.2	^	
			I _{CCL}	V _{CC} = MAX	V _{IN} = GND		7.2	9.7	mA	

- 1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.
- All typical values are at V_{CC} = 5V, T_{amb} = 25°C.
 Not more than one output should be shorted at a time. For testing I_{OS}, the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a High output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I_{OS} tests should be performed last.

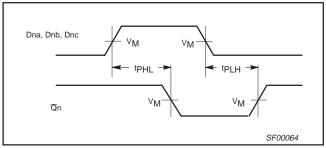
74F10, 74F11 Gates

AC ELECTRICAL CHARACTERISTICS

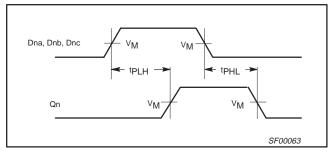
SYMBOL	PARAMETER	TEST CONDITION	Ta	CC = +5.0 amb = +25° 50pF, R _L =	C	V _{CC} = +5. T _{amb} = 0°0 C _L = 50pF,	UNIT		
			MIN	TYP	MAX	MIN	MAX	1	
t _{PLH} t _{PHL}	Propagation delay Dna, Dnb, Dnc to Qn	74F10	Waveform 1	2.4 1.5	3.7 3.2	5.0 4.3	2.4 1.5	6.0 5.3	ns
t _{PLH} t _{PHL}	Propagation delay Dna, Dnb, Dnc to Qn	74F11	Waveform 2	3.0 2.5	4.2 4.1	5.6 5.5	3.0 2.5	6.6 6.5	ns

AC WAVEFORMS

For all waveforms, $V_M = 1.5V$.

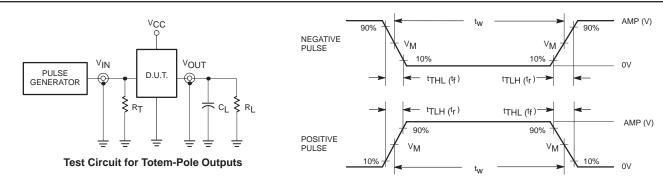


Waveform 1. Propagation Delay for Inverting Outputs



Waveform 2. Propagation Delay for Non-Inverting Outputs (74F11)

TEST CIRCUIT AND WAVEFORM



DEFINITIONS: R_L = Load resistor;

see AC ELECTRICAL CHARACTERISTICS for value. Load capacitance includes jig and probe capacitance; see AC ELECTRICAL CHARACTERISTICS for value.

Termination resistance should be equal to Z_{OUT} of $R_T =$ pulse generators.

Input Pulse Definition

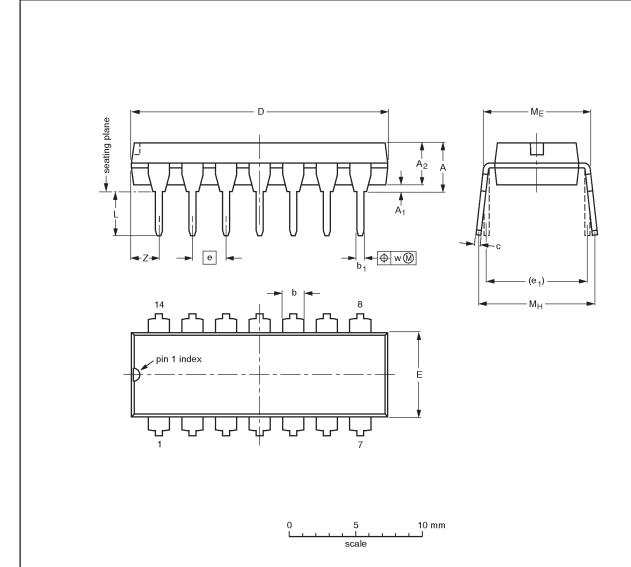
family	INP	INPUT PULSE REQUIREMENTS											
	amplitude	V_{M}	rep. rate	t _w	t _{TLH}	t _{THL}							
74F	3.0V	1.5V	1MHz	500ns 2.5ns		2.5ns							

SF00006

Gates 74F10, 74F11

DIP14: plastic dual in-line package; 14 leads (300 mil)

SOT27-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁ min.	A ₂ max.	b	b ₁	С	D ⁽¹⁾	E ⁽¹⁾	е	e ₁	L	ME	M _H	w	Z ⁽¹⁾ max.
mm	4.2	0.51	3.2	1.73 1.13	0.53 0.38	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.2
inches	0.17	0.020	0.13	0.068 0.044	0.021 0.015	0.014 0.009	0.77 0.73	0.26 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.087

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

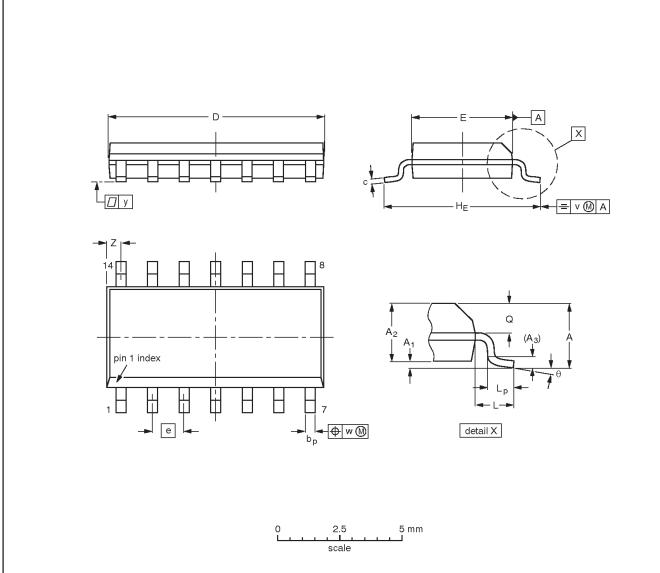
OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	PROJECTION	ISSUE DATE		
SOT27-1	050G04	MO-001AA				92-11-17 95-03-11

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SO14: plastic small outline package; 14 leads; body width 3.9 mm

SOT108-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁	A ₂	А3	bp	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	8.75 8.55	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inches	0.069	0.010 0.004	0.057 0.049	0.01		0.0100 0.0075	0.35 0.34	0.16 0.15	0.050	0.244 0.228	0.041	0.039 0.016		0.01	0.01	0.004	0.028 0.012	0°

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN	ISSUE DATE
	IEC	JEDEC	EIAJ		PROJECTION	1990E DATE
SOT108-1	076E06S	MS-012AB				-95-01-23- 97-05-22

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Data sheet status

Data sheet status	Product status	Definition [1]	
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.	
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product.	
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^[1] Please consult the most recently issued datasheet before initiating or completing a design.

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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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